

Notice of References Cited	Application/Control No. 10/849,579	Applicant(s)/Patent Under Reexamination DIPIAZZA, GERALD C.	
	Examiner EMEM EKONG	Art Unit 2688	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0176027	09-2004	O'Neill, Frank P.	455/007
*	B	US-2003/0211827	11-2003	Yonezawa et al.	455/7
*	C	US-6,895,218	05-2005	Yarkosky, Mark	455/20
*	D	US-2004/0203563	10-2004	Menard, Raymond J.	455/404.1
*	E	US-6,421,027	07-2002	Takatori et al.	343/893
*	F	US-2004/0137842	07-2004	Iwata et al.	455/012.1
*	G	US-2002/0177401	11-2002	Judd et al.	455/11.1
*	H	US-3,876,980	04-1975	Haemmig et al.	714/822
*	I	US-2001/0031623	10-2001	Masoian, Lee	455/11.1
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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